## Highly Conductive, Flexible and Stretchable Conductors Based on Fractal Silver Nanostructures

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**Figure S1** The photography of (a) the T2 sample at releasing state and (b) the T2 sample under 180° bending state.

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**Figure S2** Under 100 bending cycles (180°), the relative resistance change of (a) the T3 sample with the 1 cm width and (b) the T2 sample with the 2 cm width.



**Figure S3** Under 10,000 bending cycles (180°), the resistance change of the T2 sample

(1 cm width).



**Figure S4** The photography of (a) the T2 sample at releasing state and (b) the T2 sample under 30 % stretching state.



Figure S5 The relative resistance change of the T2 sample with the 2 cm width under

100 stretching cycles (30 %).



Figure S6 the photography of (a) the T2 sample under twisting state and (b) the T2

sample under 30 % twisting-stretching state.



**Figure S7** the photography of (a) the T2 sample at releasing state and (b) the T2

sample under 100 % stretching state.